

Overall Statistical Feature [USA, Semiconductor]

situation: beat_up

number of beat_up is: 61

Surprise

count 61.000000

mean 0.139069

std 0.144152

min 0.050300

25% 0.065500

50% 0.104300

75% 0.150000

max 0.907000situation: beat_down

number of beat_down is: 59

Surprise

count 59.000000

mean 0.129258

std 0.096229

min 0.051400

25% 0.068250

50% 0.100000

75% 0.158750

max 0.543300situation: miss_up

number of miss_up is: 4

Surprise

count 4.000000

mean 4.370900

std 7.433050

min 0.011000

25% 0.011975

50% 1.022000

75% 5.380925

max 15.428600situation: miss_down

number of miss_down is: 8

Surprise

count 8.000000

mean 0.502962

std 0.707129

min 0.016900

25% 0.021575

50% 0.256700

75% 0.630200

max 2.076900situation: fluctuate

number of fluctuate is: 19

Surprise

count 19.000000

mean 0.16620

std 0.15612

min 0.02410

25% 0.08480

50% 0.13310

75% 0.17660

max 0.74030